


<b>Search Notes</b>  	<b>Application/Control No.</b>  10563920	<b>Applicant(s)/Patent Under Reexamination</b>  HAYNES ET AL.
	<b>Examiner</b>  YOSHITOSHI TAKEUCHI	<b>Art Unit</b>  4162

SEARCHED			
Class	Subclass	Date	Examiner
			YT

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search	6/2008	YT
Consulted w/ examiner Curtis Mayes	6/2008	YT
Text search	6/2008	YT
Inventor search	9/2009	YT
Text search	9/2009	YT
Consulted w/ Stuart Hendrickson	9/2009	YT
EAST text search	9/2009	YT
Internet	9/2009	YT
Inventor search	3/2010	YT
EAST text search (PG Pub, US Pat, EPO, JPO, Derwent)	3/2010	YT
Inventor search	11/2010	YT
EAST text search (PG Pub, US Pat, EPO, JPO, Derwent)	11/2010	YT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
562	525	3/2010	YT
562	525	7/2010	YT
562	550	7/2010	YT
562	525	11/2010	YT
562	550	11/2010	YT

/YOSHITOSHI TAKEUCHI/ Examiner.Art Unit 1793	
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